		Application No.	Applicant(s)
		10/630,570	LEE ET AL.
Notic	of Allowability	Examiner	Art Unit
		Asok K. Sarkar	2829
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.			
1. This communication is responsive to Application filed 7/29/2003.			
2. The allowed claim(s) is/are <u>1-14</u> .			
3. The drawings filed on 29 July 2003 are accepted by the Examiner.			
 4. Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some* c) None of the: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No 3. Copies of the certified copies of the priority documents have been received in this national stage application from the International Bureau (PCT Rule 17.2(a)). * Certified copies not received: Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application. 			
 THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. 5. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient. 			
6. CORRECTED DRAWINGS (as "replacement sheets") must be submitted.			
(a) ☐ including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached			
1) hereto or 2) to Paper No./Mail Date			
(b) ☐ including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date			
Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d).			
7. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.			
3. Information Disclos Paper No./Mail Da	on's Patent Drawing Review (PTO-948) ure Statements (PTO-1449 or PTO/SB/ te <u>7129</u> 2003 nt Regarding Requirement for Deposit	6. Interview Summary Paper No./Mail Da 08), 7. Examiner's Amend	te

DETAILED ACTION

Allowable Subject Matter

- 1. Claims 1 14 are allowed.
- 2. The following is an examiner's statement of reasons for allowance:

Claims 1 – 13 recite, inter alia, a method of forming a silicide film of a semiconductor device comprising performing a radio frequency etching process ex-situ that removes impurities from the conductive pattern and the conduction region on the substrate and that uniformly planarizes a surface of the conduction region; and performing a cleaning process that removes residues generated during the radio frequency etching process from the conductive pattern and the conduction region. Although, it is well known to perform a cleaning process to remove residues generated by the etching process, the claimed process of cleaning the residue after ex-situ radio frequency etching process to remove impurities from the conductive pattern and the conduction region on the substrate and that uniformly planarizes the surface of the conduction region appears novel. Nutley, US 2002/0146897 teaches a similar process but fails to teach the step of removing residues generated during the radio frequency etching process. Additionally, the art of record does not disclose or anticipate the above limitation in combination with other claim elements nor would it be obvious to modify the art of record so as to form a device including the above limitation.

Claim 14 recites, inter alia, a method of forming a silicide film of a semiconductor device comprising performing a radio frequency etching process ex-situ on a resultant structure on the substrate that provides silicon in the source/drain regions having a

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uniformly amorphous phase and performing a cleaning process that removes residues generated during the radio frequency etching process. Although, it is well known to perform a cleaning process to remove residues generated by the etching process, the claimed process of cleaning the residue after ex-situ radio frequency etching process of the source and drain regions appears novel. Nutley, US 2002/0146897 teaches a similar process but fails to teach the step of removing residues generated during the radio frequency etching process. Additionally, the art of record does not disclose or anticipate the above limitation in combination with other claim elements nor would it be obvious to modify the art of record so as to form a device including the above limitation.

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Conclusion

- 3. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."
- 4. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Kamal, US 6,303,503 teaches a method of forming silicide employing a sputter etch process.
- 5. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Asok K. Sarkar whose telephone number is 571 272 1970. The examiner can normally be reached on Monday Friday (8 AM- 5 PM).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Kammie Cuneo can be reached on 571 272 1957. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

6. Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Asok K. Sarkar May 11, 2004

Patent Examiner

ParilA. Farnele Primary Example 5/14/04